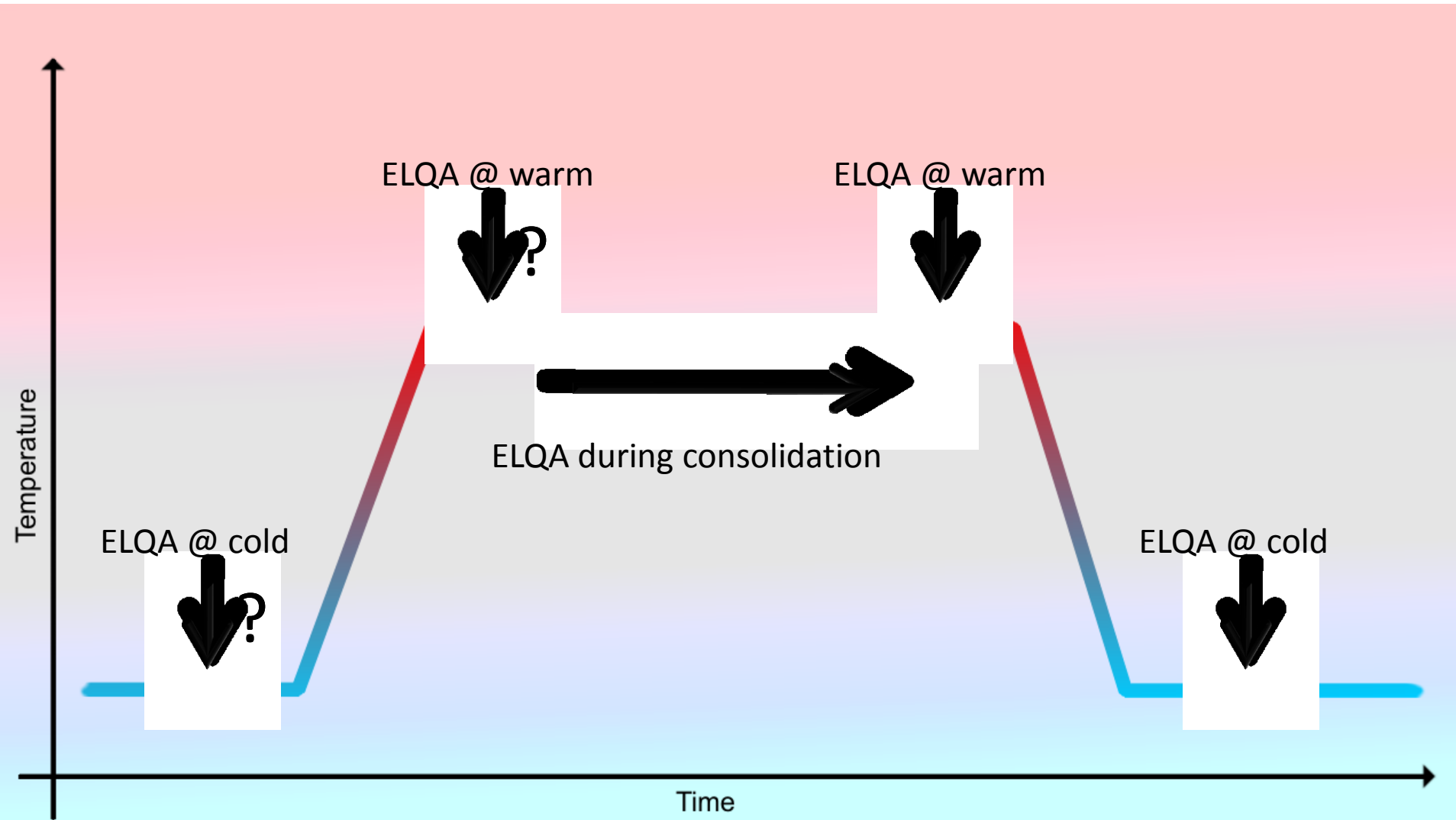


Additional measurements and diagnostics – status and plans for the long shutdown

- ELQA vs. general planning
 - ELQA procedure overview,
 - Advantages of additional campaigns,
 - Its disadvantages,
- Insulation monitoring system,
- What new tests could be introduced,
- Machine layout modifications which could make QA more efficient.



LHC long shut-down planning

Advantages:

- Better understanding of changes in the circuits,
 - During many current cycles and the beam operation some aging process could have taken place. We should know the tendency as soon as possible in order to profit from the long shut-down and to react,
- If we discover any problems
 - There will be time to treat them,
 - It won't delay the physics run,
- We can apply more restrictive voltage withstand criteria,
- We can test with a higher precision certain parameters (TFM, resistance checks) with upgraded HW and SW:
 - Possibly new NCs,
 - Reference for the future,
- Certain parameters are accessible only at warm, some others at cold – both suggested campaigns are needed.

Disadvantages:

- We need a time slot – probably 2-4 weeks per campaign (@warm, @cold),
- We need some resources to fit in the 2-4 weeks time window
 - Shift work,
 - Engineers and technicians from collaborations as it was in previous campaigns,
- If we discover a break-down during the HV test close to the testing voltage
 - We might not be able to localize it at warm (lower test voltages),
 - Might need to foresee a time slot for investigations,
 - Not absolutely true that during the shut-down we can fix whatever comes.

HV monitoring of the electrical insulation of the selected circuits during the warm-up and cool-down phases.

- Some software tuning would be appreciated but for the moment the applications are stable enough,
- We keep max 48 V for security reasons,
- Do we need to monitor all the circuits powered via DFBA's or we should stay with monitoring only the main ones?
 - Some software improvements needed for monitoring more than about 10-15 circuits
- Would it be interesting to monitor the inner triplet magnets or the ones powered via the DFBLs (link)?
 - We might be missing some hardware

- Corrector circuits resistance measurements at cold (splices)
 - Type test needed, the best if it could be performed in January or February 2011 during powering tests
- Splice measurements after ICs are redone
 - Is it possible/useful at warm?
 - Possible resources sharing point
- New possibilities with new devices like PowerTek Gain Phase Analyzer and upgraded TP4 system:
 - Improved TFM vs. GND – precision to be evaluated – quality of the insulation information,
 - Measurement of the protection diode characteristics (RB, RQD, RQF magnets) – application (and hardware) to be developed,
 - Faulty QH recognition – up to now no good method exists, needs to be studied in more details.

- Additional V-taps?
 - New V-taps in CC?
 - Better to have protection resistors...
- In order to ease the test of insulation between two conductors maybe we could install an additional DFB at the end of the circuit like in RB? It could be placed instead of the CC.
 - MCS circuit case where TFM shown shorted bus-bars
 - Insulation might be weak (breakdown at HV)
- What about connecting some spools and some Line N circuits to the 'spare' CLs? It would help to understand how do the low current splices work.



Questions?



Thank you for your attention!